

Device Modeling Report

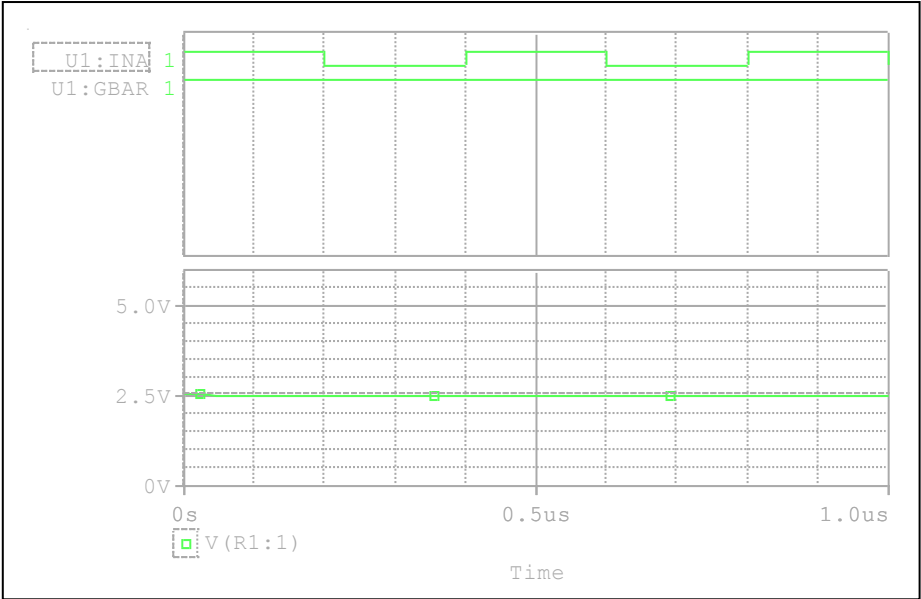
COMPONENTS : CMOS DIGITAL INTEGRATED CIRCUIT
PART NUMBER : TC7SZ125FU
MANUFACTURER : TOSHIBA



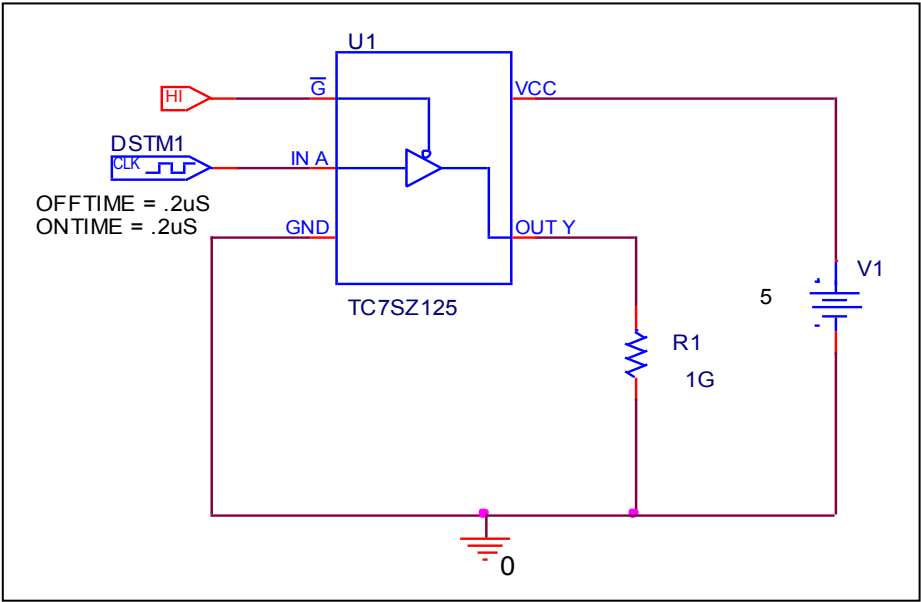
Bee Technologies Inc.

Truth Table

Circuit simulation result



Evaluation circuit

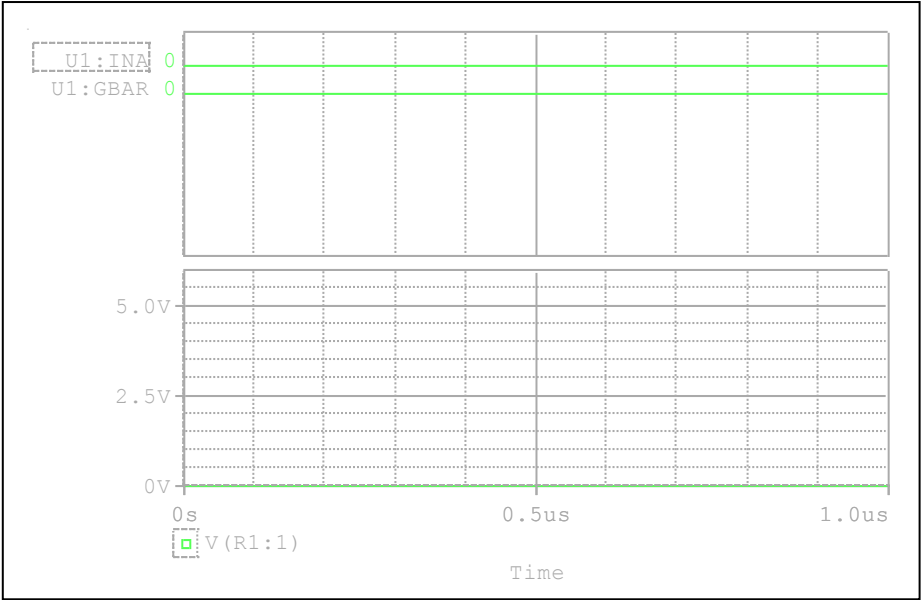


Comparison table

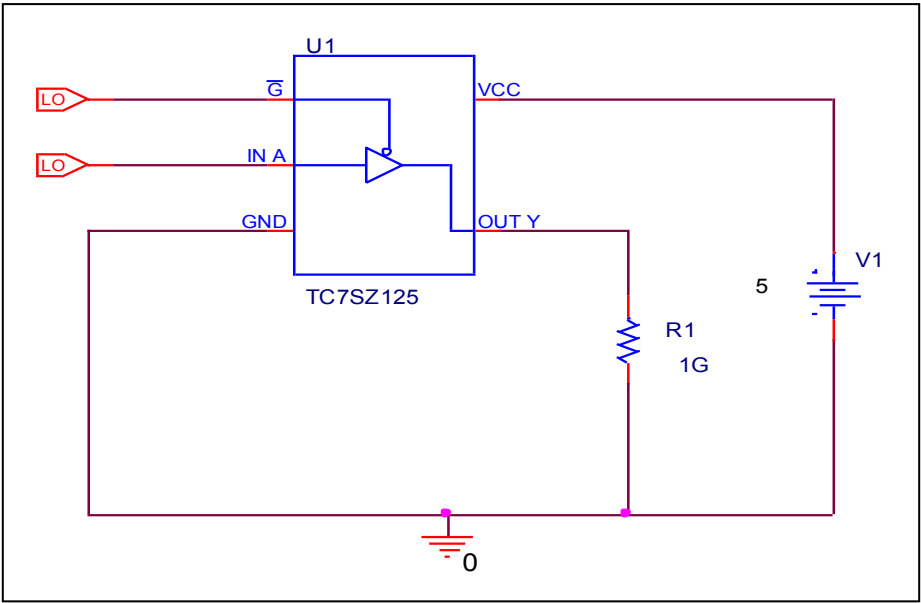
Input		Output		%Error
A	$\overline{G}$	Y (Measurement)	Y (Simulation)	
X	H	Z	Z	0

Truth Table

Circuit simulation result



Evaluation circuit

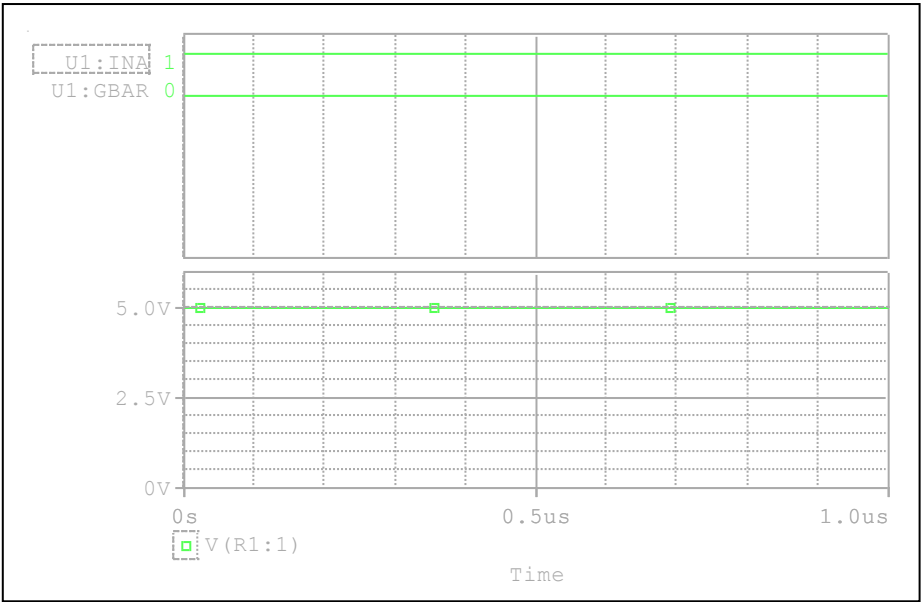


Comparison table

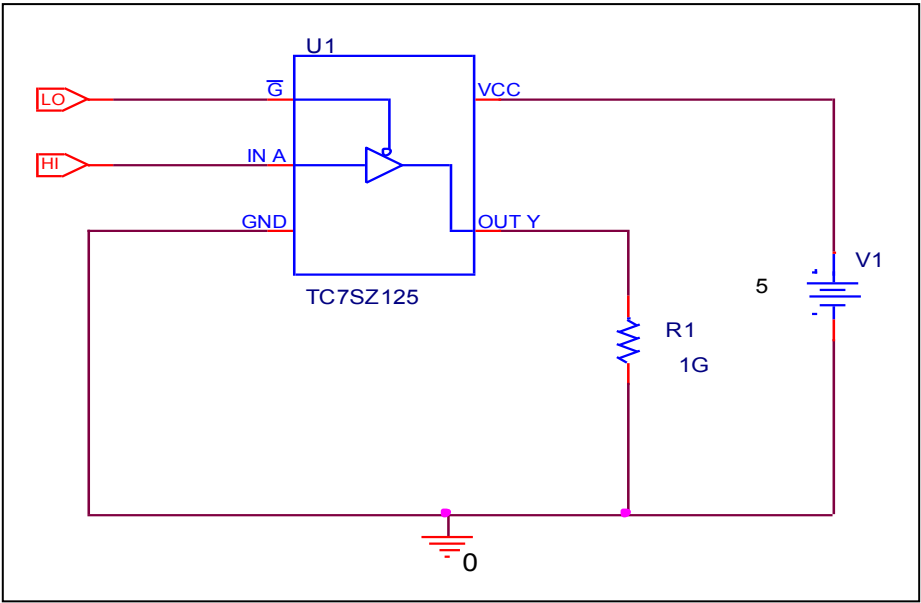
Input		Output		%Error
A	$\overline{G}$	Y (Measurement)	Y (Simulation)	
L	L	L	L	0

Truth Table

Circuit simulation result



Evaluation circuit

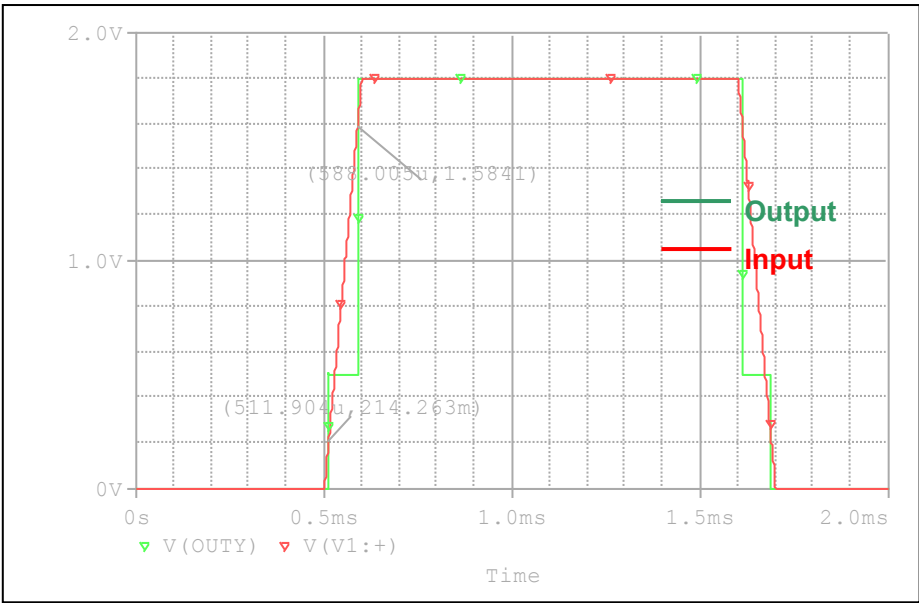


Comparison table

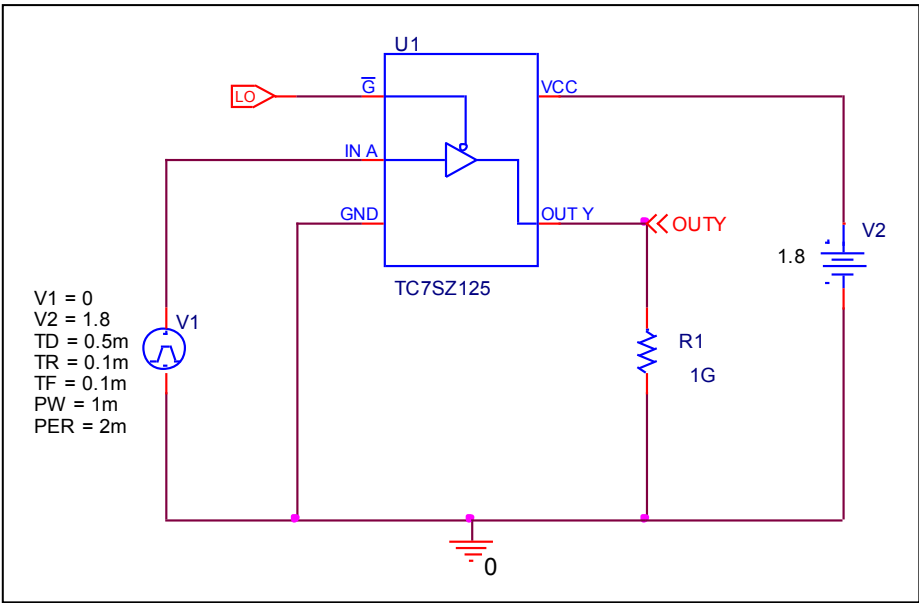
Input		Output		%Error
A	$\bar{G}$	Y (Measurement)	Y (Simulation)	
H	L	H	H	0

High Level and Low Level Input Voltage ($V_{CC} = 1.8\text{ V}$)

Circuit simulation result



Evaluation circuit

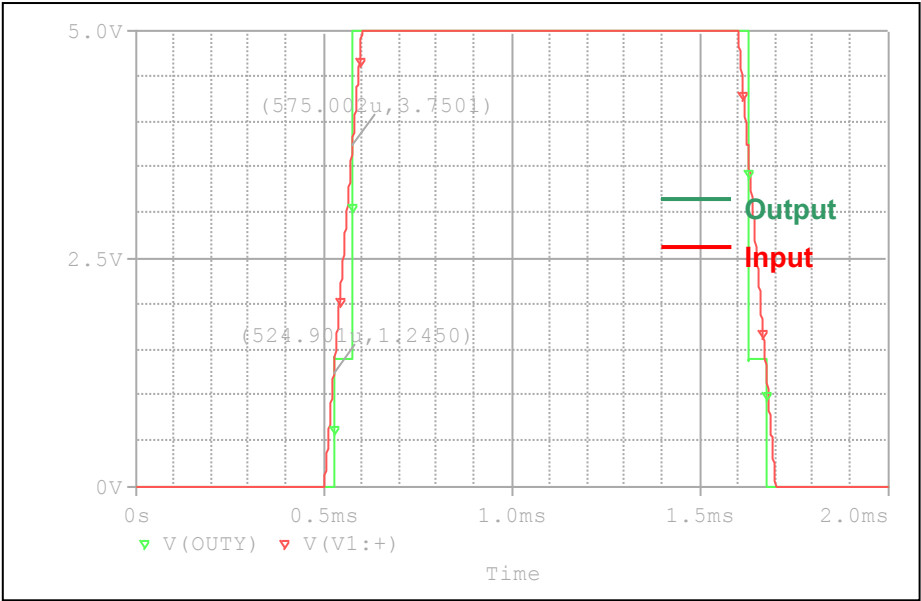


Comparison table

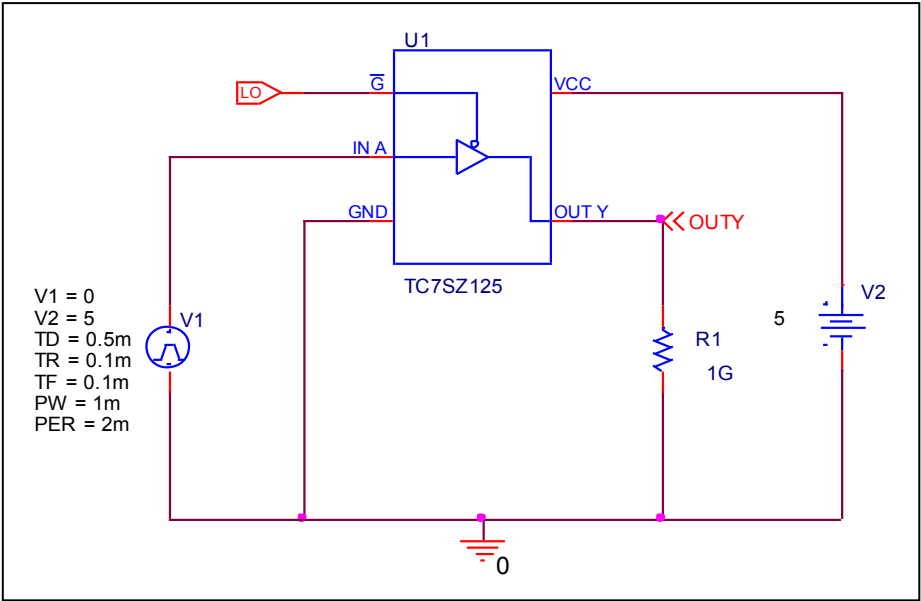
$V_{CC} = 1.8\text{ V}$	Measurement	Simulation	%Error
Min $V_{IH} = (0.88 \cdot V_{CC})\text{ V}$	1.584	1.5841	0.006
Max $V_{IL} = (0.12 \cdot V_{CC})\text{ V}$	0.216	0.214263	-0.804

High Level and Low Level Input Voltage ($V_{CC} = 5\text{ V}$)

Circuit simulation result



Evaluation circuit

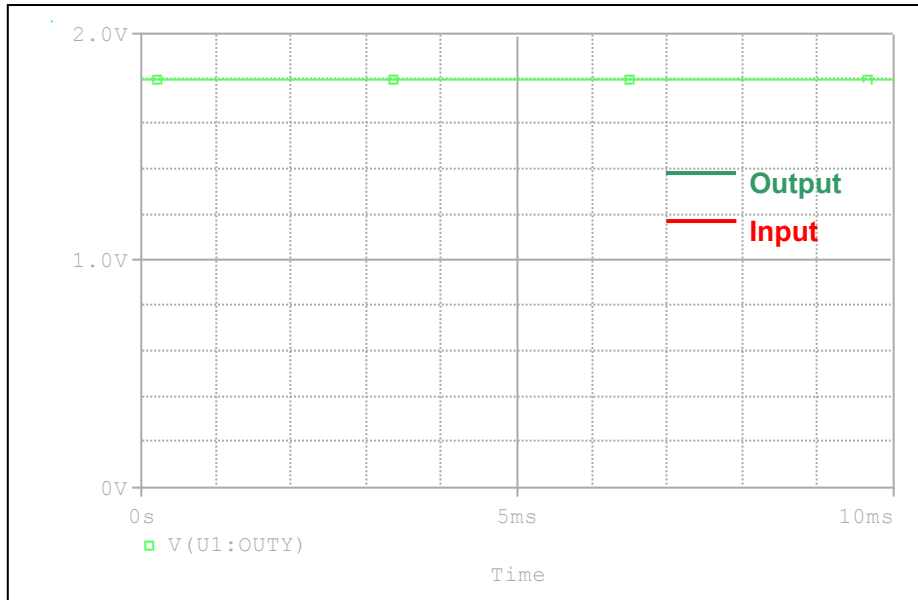


Comparison table

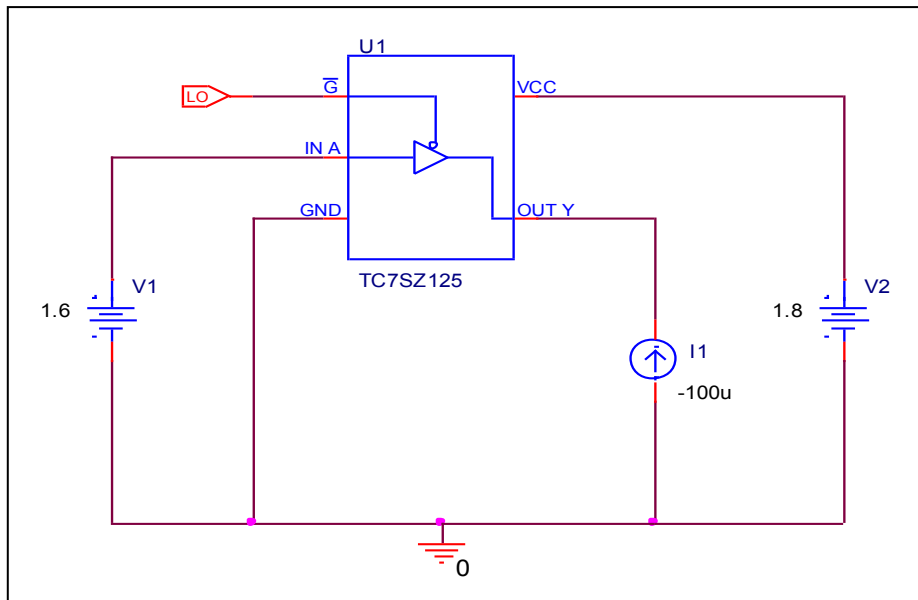
$V_{CC} = 5\text{ V}$	Measurement	Simulation	%Error
Min $V_{IH} = (0.75 \cdot V_{CC})\text{ V}$	3.75	3.7501	0.003
Max $V_{IL} = (0.25 \cdot V_{CC})\text{ V}$	1.25	1.2450	-0.400

High Level Output Voltage ($V_{CC} = 1.8 \text{ V}$)

Circuit simulation result



Evaluation circuit

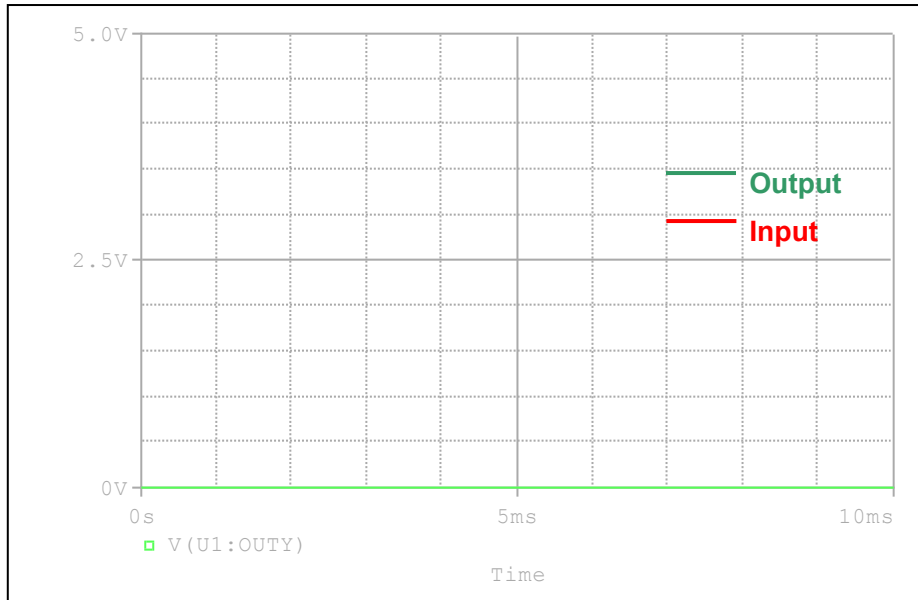


Comparison table

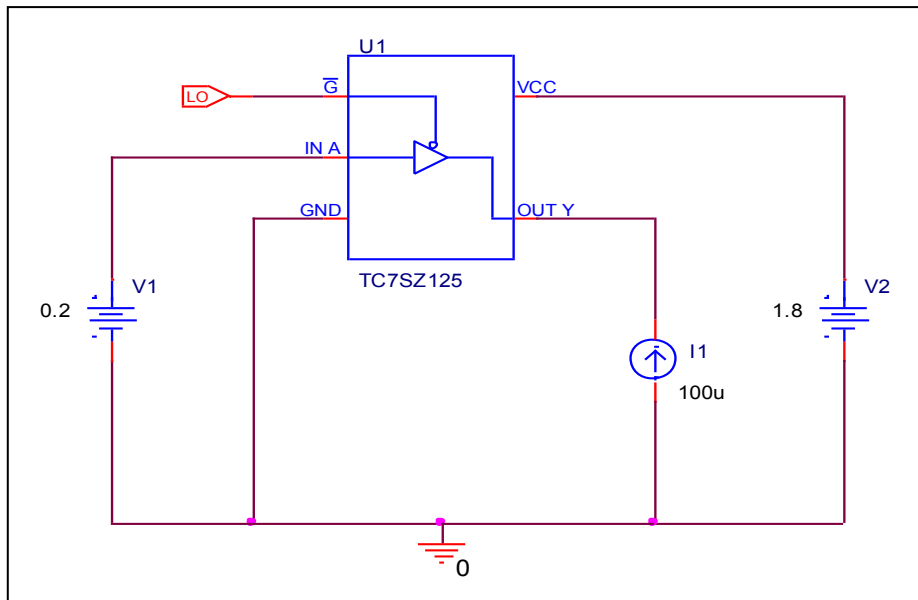
$V_{IN} = V_{IH}, V_{CC} = 1.8 \text{ V}$	Measurement	Simulation	%Error
$V_{OH} \text{ (V)}$	1.8	1.7999	-0.006

Low Level Output Voltage ($V_{CC} = 1.8\text{ V}$)

Circuit simulation result



Evaluation circuit

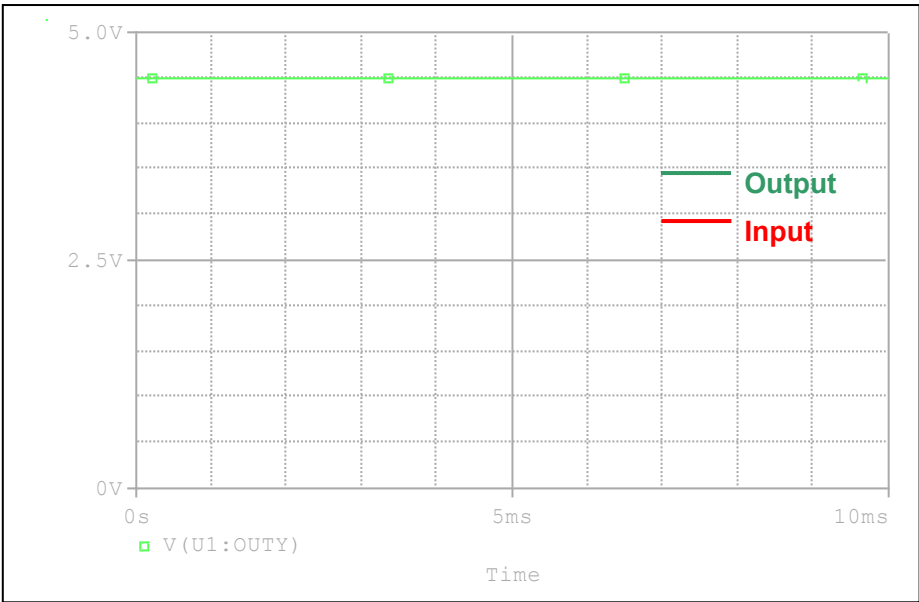


Comparison table

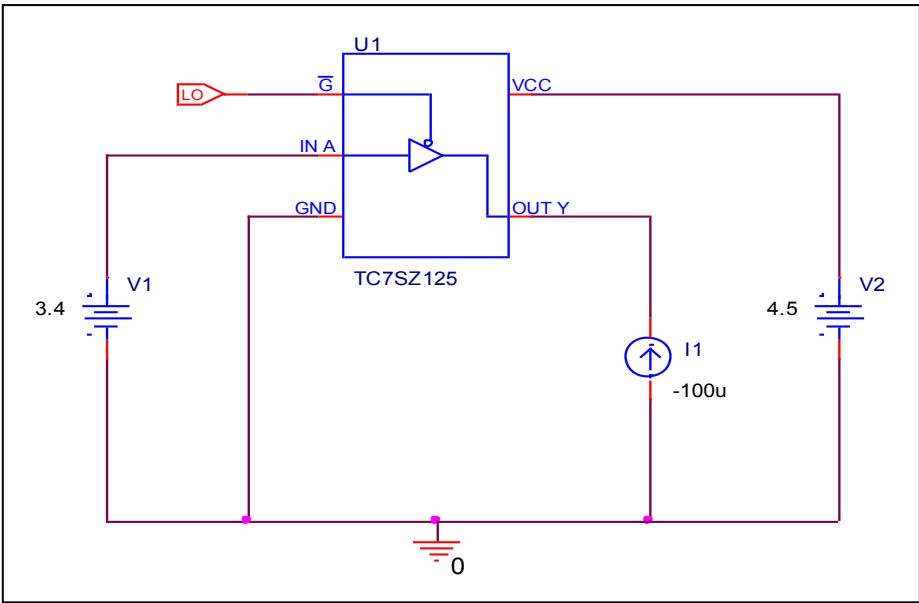
$V_{IN} = V_{IL}, V_{CC} = 4.5\text{ V}$	Measurement	Simulation	%Error
$V_{OL}\text{ (V)}$	0	0	0

High Level Output Voltage ($V_{CC} = 4.5\text{ V}$)

Circuit simulation result



Evaluation circuit

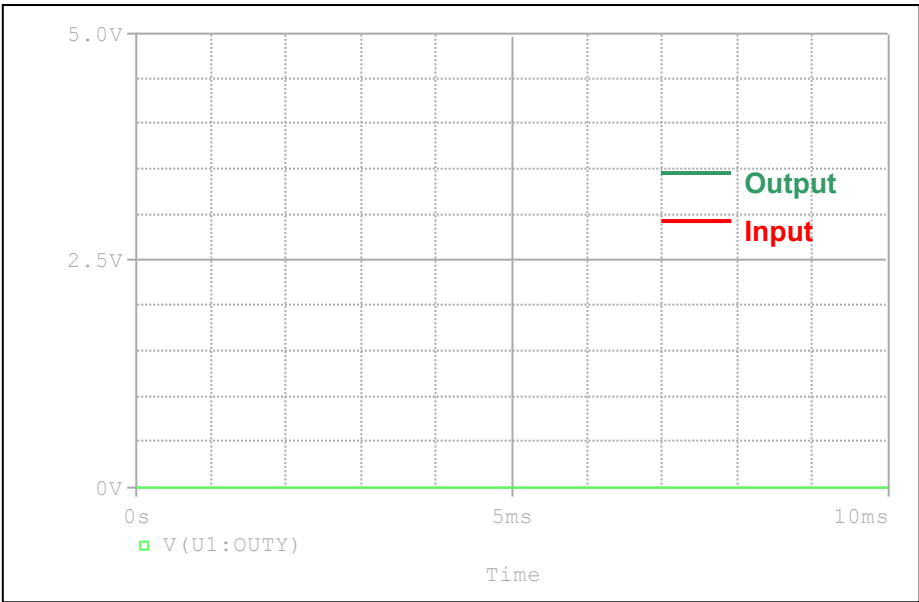


Comparison table

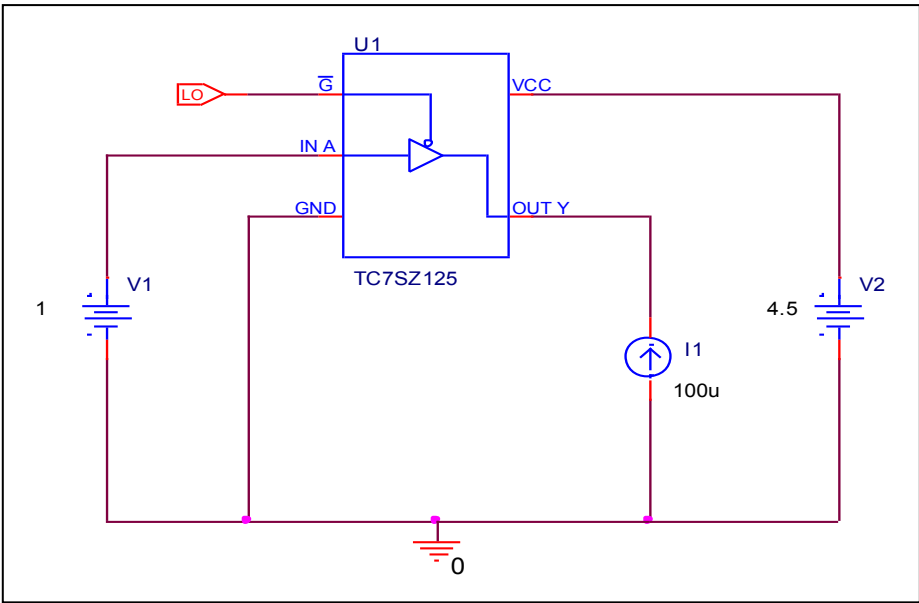
$V_{IN} = V_{IH}, V_{CC} = 4.5\text{ V}$	Measurement	Simulation	%Error
$V_{OH}\text{ (V)}$	4.5	4.4991	-0.02

Low Level Output Voltage ($V_{CC} = 4.5\text{ V}$)

Circuit simulation result



Evaluation circuit

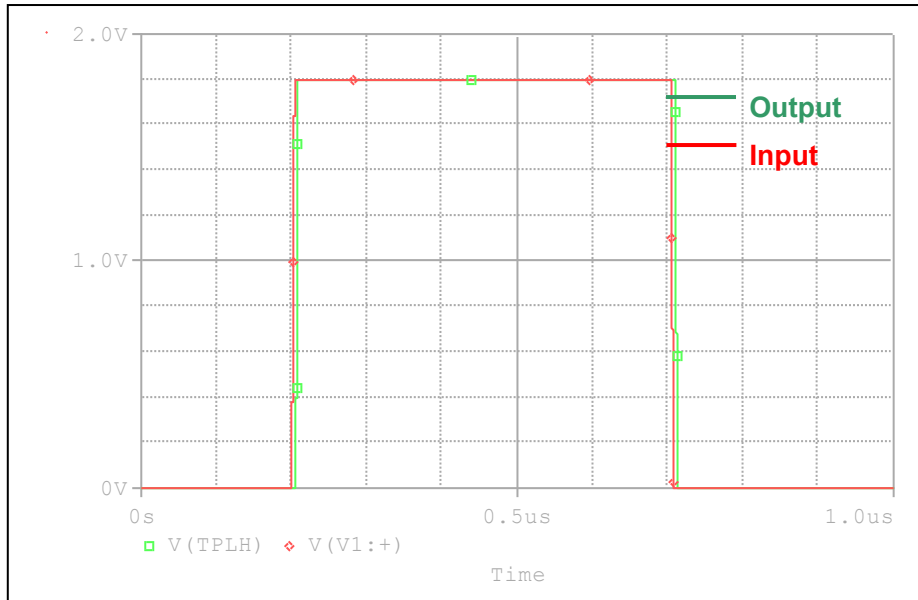


Comparison table

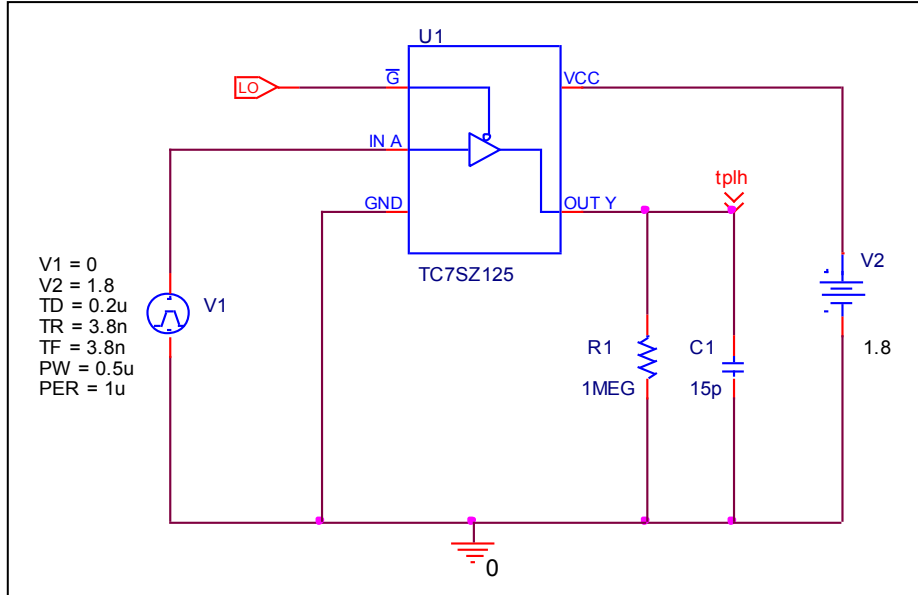
$V_{IN} = V_{IL}, V_{CC} = 4.5\text{ V}$	Measurement	Simulation	%Error
$V_{OL}\text{ (V)}$	0	0	0

Propagation Delay Time ($V_{CC} = 1.8\text{ V}$)

Circuit simulation result



Evaluation circuit

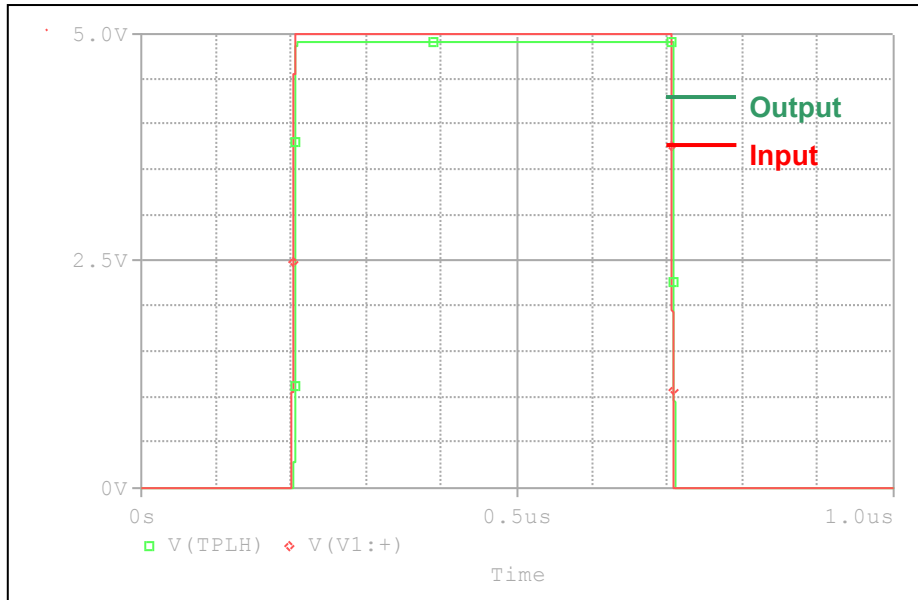


Comparison table $C_L = 15\text{ pF}$, $R_L = 1\text{ M}\Omega$

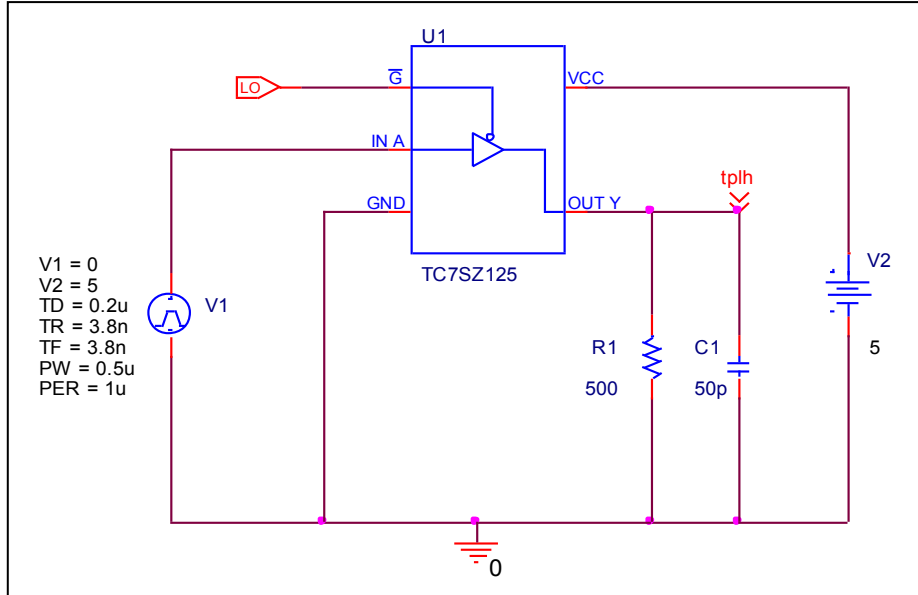
$V_{CC} = 1.8\text{V}$, $t_r = t_f = 3\text{ ns}$	Measurement	Simulation	%Error
$t_{PLH}\text{ (ns)}$	5.3	5.3208	0.392
$t_{PHL}\text{ (ns)}$	5.3	5.3079	0.149

Propagation Delay Time ($V_{CC} = 5\text{ V}$)

Circuit simulation result



Evaluation circuit

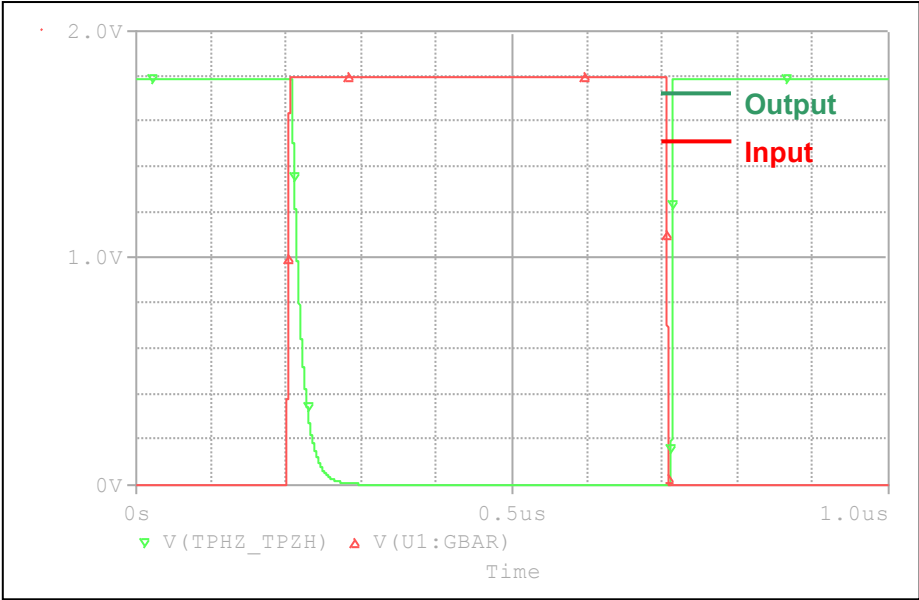


Comparison table $C_L = 50\text{ pF}$, $R_L = 500\text{ }\Omega$

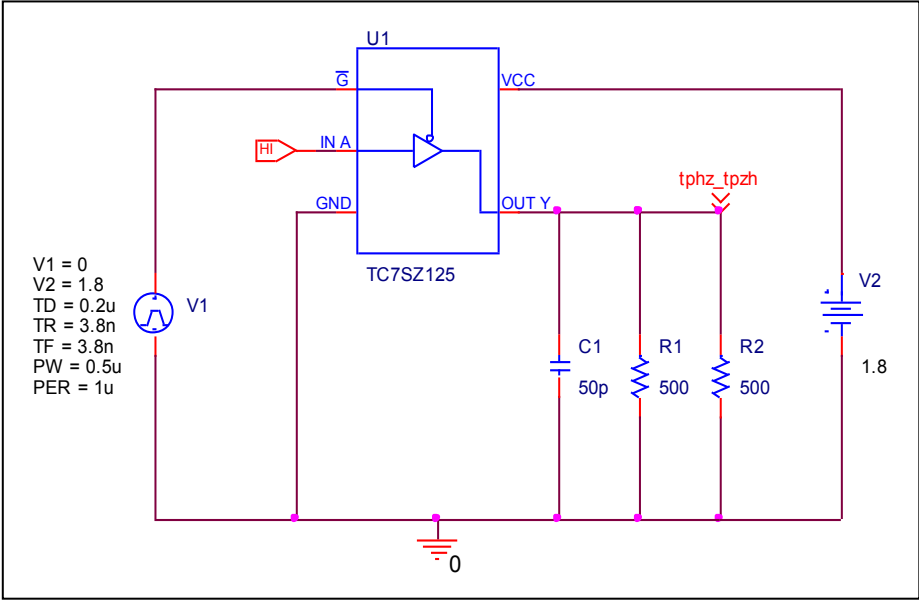
$V_{CC} = 5\text{ V}$, $t_r = t_f = 3\text{ ns}$	Measurement	Simulation	%Error
$t_{PLH}\text{ (ns)}$	2.6	2.6444	1.708
$t_{PHL}\text{ (ns)}$	2.6	2.6279	1.073

Output enable time(t_{PZH}) and Output disable time(t_{PHZ}) ($V_{CC} = 1.8\text{ V}$)

Circuit simulation result



Evaluation circuit

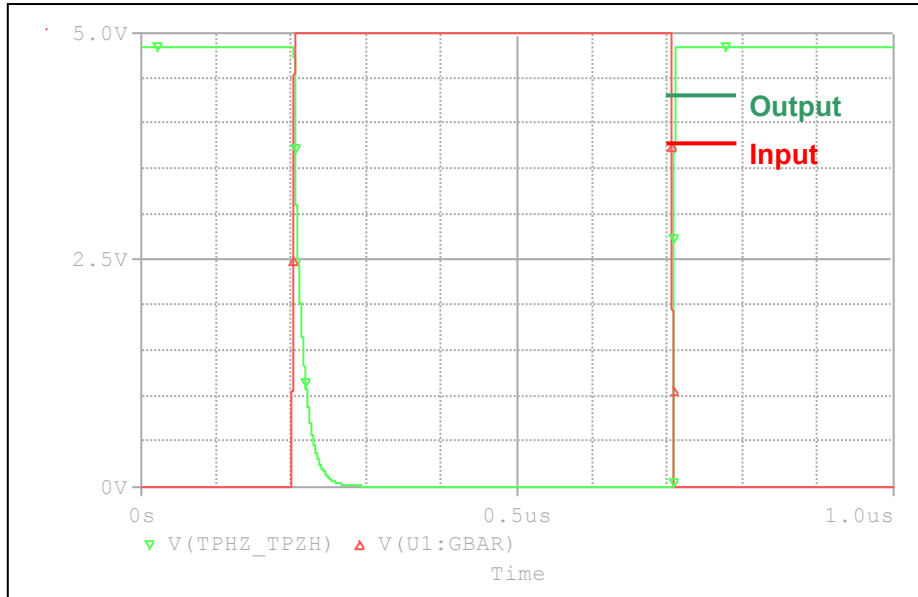


Comparison table $C_L = 50\text{ pF}$, $R_L = 500\text{ }\Omega$

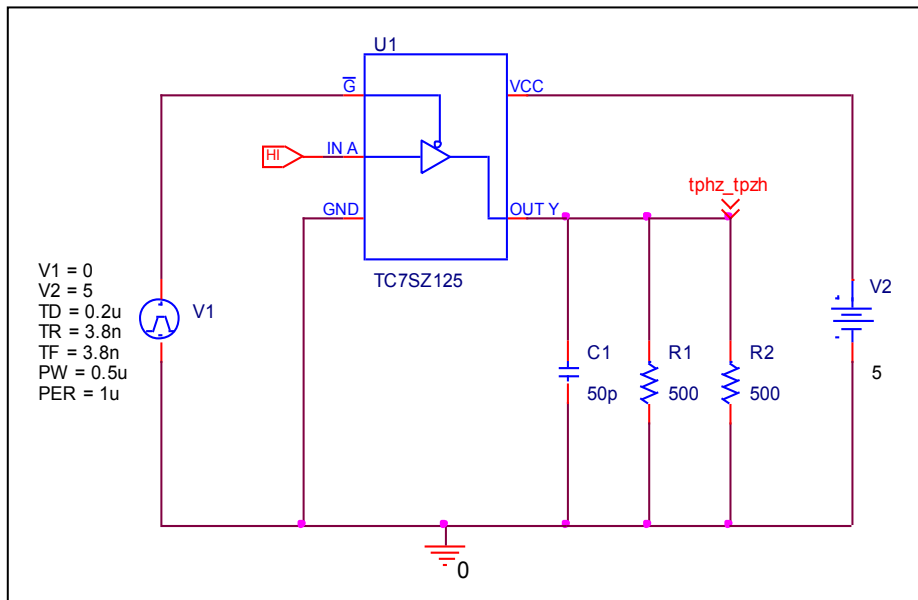
$V_{CC} = 1.8\text{V}$, $t_r = t_f = 3\text{ ns}$	Measurement	Simulation	%Error
$t_{PZH}\text{ (ns)}$	7	7.0535	0.764
$t_{PHZ}\text{ (ns)}$	5.4	5.4334	0.619

Output enable time(t_{PZH}) and Output disable time(t_{PHZ}) ($V_{CC} = 5\text{ V}$)

Circuit simulation result



Evaluation circuit

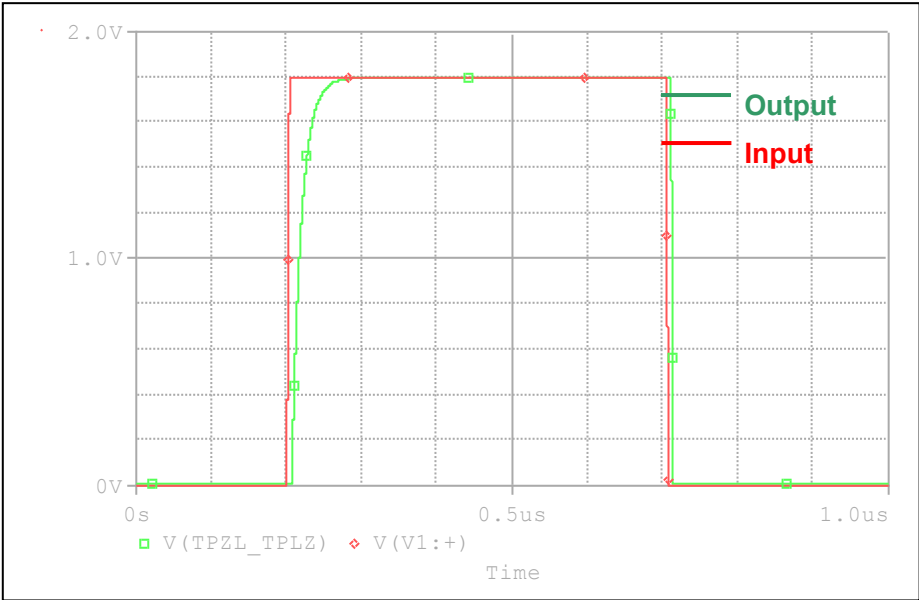


Comparison table $C_L = 50\text{ pF}$, $R_L = 500\text{ }\Omega$

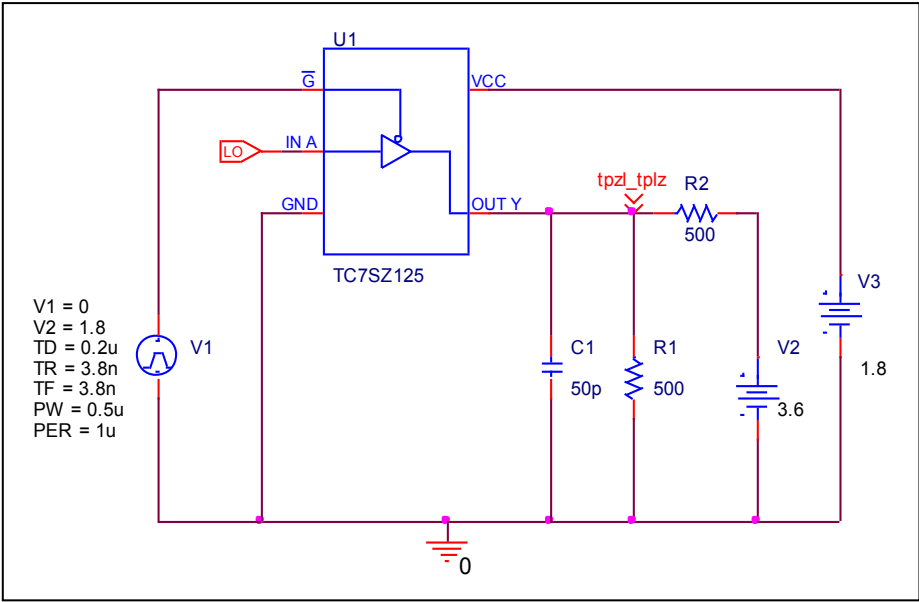
$V_{CC} = 5\text{ V}$, $t_r = t_f = 3\text{ ns}$	Measurement	Simulation	%Error
$t_{PZH}\text{ (ns)}$	2.8	2.7773	-0.811
$t_{PHZ}\text{ (ns)}$	2.1	2.1849	4.043

Output enable time(t_{PZL}) and Output disable time(t_{PLZ}) ($V_{CC} = 1.8\text{ V}$)

Circuit simulation result



Evaluation circuit

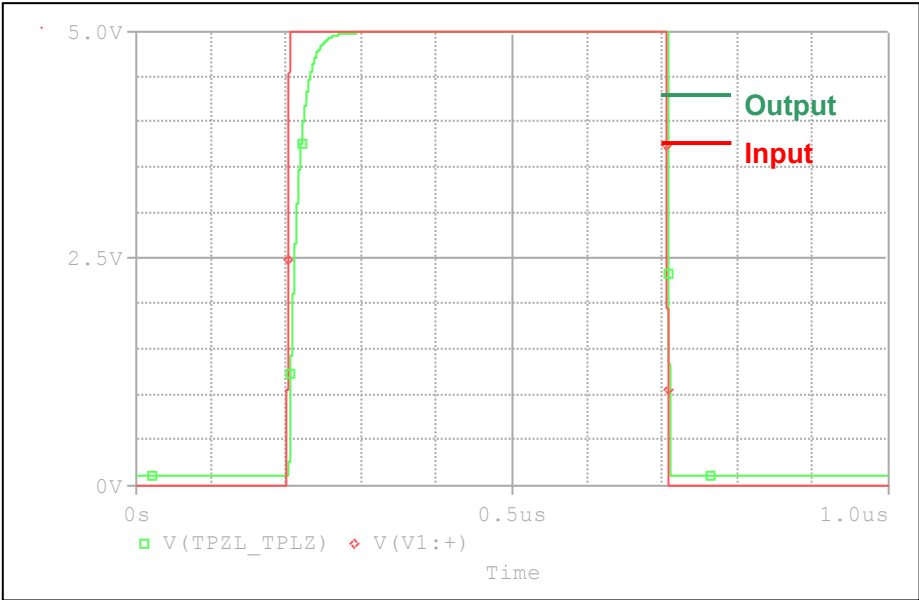


Comparison table $C_L = 50\text{ pF}$, $R_L = 500\text{ }\Omega$

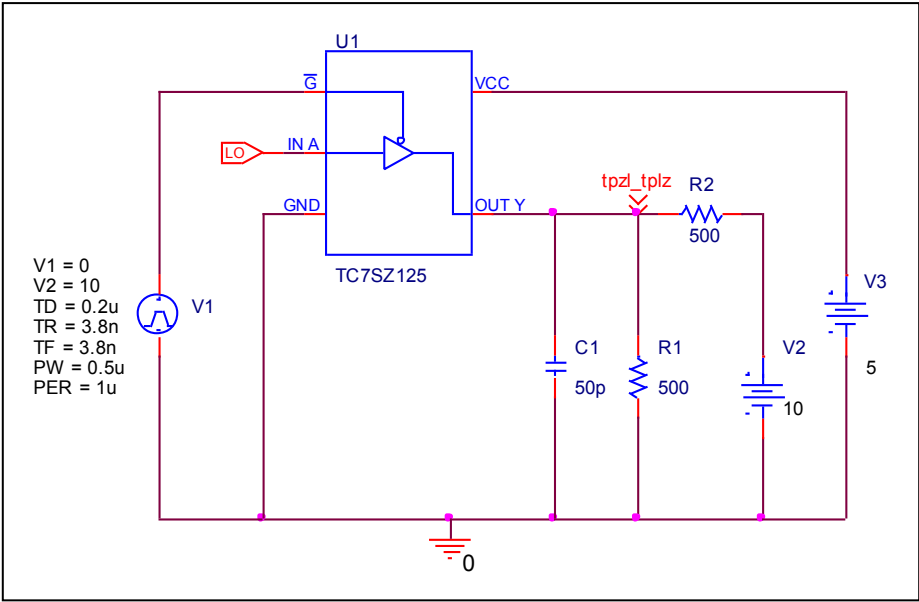
$V_{CC} = 1.8\text{ V}$, $t_r = t_f = 3\text{ ns}$	Measurement	Simulation	%Error
$t_{PZL}\text{ (ns)}$	7	7.0213	0.304
$t_{PLZ}\text{ (ns)}$	5.4	5.4336	0.622

Output enable time(t_{PZL}) and Output disable time(t_{PLZ}) ($V_{CC} = 5\text{ V}$)

Circuit simulation result



Evaluation circuit



Comparison table $C_L = 50\text{ pF}$, $R_L = 500\text{ }\Omega$

$V_{CC} = 5\text{ V}$, $t_r = t_f = 3\text{ ns}$	Measurement	Simulation	%Error
$t_{PZL}\text{ (ns)}$	2.8	2.7927	-0.261
$t_{PLZ}\text{ (ns)}$	2.1	2.1048	0.229